

1. Scope

This specification is applies to Multilayer Ceramic Chip Capacitor (MLCC) for use in electric equipment for the voltage is ranging from 100V to 5KV.

The MLCC support for Lead-Free wave and reflow soldering, and electrical characteristic and reliability are same as before. (This product compliant with the RoHS.)

2. Parts Number Code

С	0805	X	472	K	501	Т
(1)	(2)	(3)	(4)	(5)	(6)	(7)

(1)Product

Product Code	
С	Multilayer Ceramic Chip Capacitor
(A) (C)	

(2)Chip Size

	~	
Code	Length×Width	unit : mm(inch)
0201	0.60× 0.30	(.024× .011)
0402	1.00× 0.50	(.039× .020)
0603	1.60× 0.80	(.063× .031)
0805	2.00× 1.25	(.079× .049)
1206	3.20× 1.60	(.126× .063)
1210	3.20× 2.50	(.126× .098)
1808	4.60× 2.00	(.181× .079)
1812	4.60× 3.20	(.181× .125)
1825	4.60× 6.35	(.181× .250)
2208	5.70× 2.00	(.220× .197)
2211	5.70× 2.80	(.220× .110)
2220	5.70× 5.00	(.220× .197)
2225	5.70× 6.35	(.220× .250)
		· · · · · · · · · · · · · · · · · · ·

(3) Temperature Characteristics

Cod€	Гemperatur€	Temperature	Temperature
	haracteristi	Range	Coefficient
N	NPO	-55°℃~+125°℃	30 ppm/°C
L	SL	-30°C ~+85°C	+350~-1000ppm
X	X7R	-55℃~+125℃	± 15%
В	X5R	-55°C ~+85°C	± 15%
S	X6S	-55°C ~+105°C	± 22%
Υ	Y5V	-30°C ~+85°C	+22/-82%
Z	Z5U	+10°℃~+85°℃	+22/-56%
Е	Y5U	-30°C ~+85°C	+22/-56%

(4)Capacitance

(4)Capacitance	unit :pico farads(pF)
Code	Nominal Capacitance (pF)
5R0	5.0
120	12.0
151	150.0
472	4,700.0
103	10,000.0
474	470,000.0
105	1,000,000.0
106	10,000,000.0

*. If there is a decimal point, it shall be expressed by an

(5) Capacitance Tolerance

Code	Tolerance	Nominal Capacitance
В	± 0.10 pF	Less Than 10 pF
С	± 0.25 pF	(Include 10 pF)
D	± 0.50 pF	
E	± 1.00 pF	_
F	± 1.00 %	More Than 10 pF
G	± 2.00 %	
J	± 5.00 %	
K	± 10.0 %	_
М	± 20.0 %	
Z	+80/-20 %	

(6)Rated Voltage

Code	Rated Voltage (Vdc)
101	100
201	200
251	250
501	500
631	630
102	1,000
202	2,000
252	2,500
302	3,000
502	5,000

(7)Tapping

Code	Туре
Т	Tape & Reel
В	Bulk

English capital letter R

Page: 1/15



3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

Class	Characteristic	Tolera	ance	Nominal Capacitance
I	NPO / SL	Less Then 10 pF	B (± 0.10 pF)	0.5,1,1.5,2,2.5,3
			C (± 0.25 pF)	0.5,1,1.5,2,2.5,3,3.5,4,4.5,5
			D (± 0.50 pF)	5,6,7,8,9,10
			E (± 1.00 pF)	6,7,8,9,10
		More Than 10 pF	F (±1.00 %)	E-12, E-24 series
			G (±2.00 %)	
			J (± 5.00 %)	
			K (± 10.0 %)	
П	X7R/X5R/X7E	K (± 10.0 %),	M (± 20.0 %)	E-3, E-6 series
	Y5V	M (± 20.0 %), Z	Z(+80/-20 %)	E- 3 series
	Z5U			
	Y5U			

3.2 E series(standard Number)

Standard No.	Application Capacitance											
E- 3	1.0					2	.2			4	.7	
E- 6	1.	.0	1	.5	2	.2	3	.3	4	.7	6	.8
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
E-24	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
	1.1	1.3	1.6	2.0	2.4	3.0	3.6	4.3	5.1	6.2	7.5	9.1

4. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
I	NPO	-55°C ~ +125°C	25 ℃
	SL	-25°C ~ +125°C	25 ℃
П	X7R	-55℃ ~ +125℃	25 ℃
	X5R	-55℃ ~ +85℃	25 ℃
	X6S	-55°C ~ +105°C	25 ℃
	Y5V	-30°C ~ +85°C	25 ℃
	Z5U	+10°C ~ +85°C	25 ℃
	Y5U	-30°C ~ +85°C	25 ℃
	Other	-25℃ ~ +85℃	25 ℃

5. Storage Condition

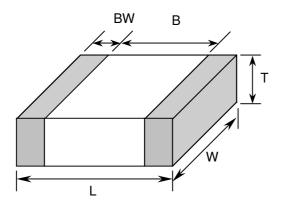
Storage Temperature : 5 to 40° C Relative Humidity : 20 to 70 % Storage Time : 12 months max.

Page: 2/15



6. Dimensions

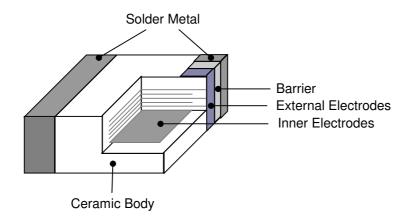
6.1 Configuration and Dimension:



Unit:mm

TYPE	L	W	Т	B (min)	BW (min)
0805	2.00± 0.20	1.25± 0.20	0.85± 0.10	0.70	0.20

6.2 Termination Type:





7. Performance

				\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	T . O		
No.	Item			Specification	Test Condition		
1	Visua			exterior appearance	Visual inspection		
2	Dimens	sion	See Page 3		Visual inspection		
3	Insulati Resista		10,000MΩ or Product Whice	500/CΩ chever Is Smaller	V≦500V, Rated Voltage V>500V, Applied 500Vdc Charge Time: 60sec. Is applied less than 50mA current.		
4	Capacitance	Class ī	Within The Sp	ecified Tolerance	Class I:		
		NPO/SL			NPO/SL		
		Class	Within The Sp	ecified Tolerance	CapacitanceFrequencyVoltageC≤100pF1MHz±10%1.0±0.2VrmsC>100pF1KHz±10%		
5	Q	Class	More Than 30	pF : Q ≧ 1000	Class ∏:		
		I	30pF & Below	: Q ≥ 400 + 20C	Frequency Voltage		
		NPO/SL	(C : Capacita	ince , pF)	X7R 1KHz±10% 1.0±0.2Vrms Z5U/Y5U 1KHz±10% 1.0±0.2Vrms		
	Tan δ	Class	Char.	Maximum	Perform a heat temperature at 150±5°C for		
		П	X7R Z5U/Y5U	2.5% 4.0%	30min. then place room temp. for 24±2hr.		
7	Withstan Voltag Temperature Capacitance Coefficient	ge	mechanical b Char. Temp. F NPO -55°C ~- SL -30°C ~+ Char. Temp. F	Range Cap. Change(%) +125°C ± 30 ppm/°C -85°C +350~-1000ppm Range Cap. Change(%)	[C2-C1/C1(T2-T1)] × 100% Class II : (C2-C1)/C1 × 100%		
	Adhaaiya S	П	X7R -55℃ ~- Y5U -30℃ ~ Z5U +10℃ ~	+125°C ± 15% +85°C +22% ~-56% +85°C +22% ~-56%	T1: Standard temperature (25°C) T2: Test temperature C1:Capacitance at standard temperature(25°C) C2: Capacitance at test temperature (T2)		
8	Adhesive S of Termin	ation	the terminal el		A 5N·f (≒0.5Kg·f) pull force shall be applied for 10± 1 second. 5N·f		
9	Resistance to	Appear- ance	No mechanica	ıl damage shall be occur.	Bending shall be applied to the 1.0 mm with		
	Flexure of Substrate		Capacitance C Char. NPO SL X7R Y5U/Z5U	Change Cap. Change ≤ ± 5.0% ≤ ± 5.0% ≤ ± 12.5% ≤ ± 30.0%	Bending Limit C Meter 45±1mm 45±1mm		



No.	Iter	n		Speci	ification	Test Condition		
10	Soldera	ability	is to be	More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve .		Solder Temperature : 245±5°C Dip Time : 5 ± 0.5 sec. Immersing Speed : 25±10% mm/s Solder : H63A Flux :Rosin Preheat : 4t 80~120 °C for 10~30sec		
11	Resistance To Soldering Heat	Appear- ance Capacit- ance	Class I (NPO/S	aracteristic I SL) X7R Z5U/Y5U	Cap. Change Within ± 2.5% or ±0.25pFwhichever is larger of initial value Within ± 10% Within ± 20% ified initial value	Preheat : At 80~120 °C for 10~30sec. Class II capacitor shall be set for 48±4 hours room temperature after one hour heat treatment at 150 +0/-10 °C before initial measure. Preheat : At 150± 10 °C For 60~120sec. Dip : Solder Temperature of 260± 5 °C Dip Time : 10 ± 1sec. Immersing Speed : 25±10% mm/s Solder : H63A		
		Resistance	To sati	sfy the spec	ified initial value ified initial value ified initial value	Flux :Rosin Measure at room temperature after cooling for Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours		
12	Tempera ture Cycle	Appear- ance Capacit- ance Q Class I	Class II To satis	Exacteristic SL) X7R Z5U/Y5U sfy the speci	Cap. Change Within ± 2.5% or ±0.25pFwhichever is larger of initial value Within ± 7.5% Within ± 20% ified initial value	the temperature cycle as following: Step		
		Class II Insulation Resistance	To sati	sfy the spec	ified initial value	Measure at room temperature after cooling for Class I :24 ± 2 Hrs Class II :48 ± 4 Hrs Solder the capacitor on P.C. board shown in Fig 2. before testing.		
13	Humidity	Appearance Capacitance Q Class I Tan δ Class II Insulation Resistance	Chair Class II Class II More T 30pF 8 Ch X7 Z5U,	racteristic [SL) X7R Z5U/Y5U Than 30pF: Below: Q ≧ nar. 7R /Y5U MΩ or 50/C	Cap. Change Within ± 5.0% or ±0.5pF whichever is larger of initial value Within ± 15% Within ± 30% Q ≥ 350 ≥ 275 + 2.5×C Maximum 5.0% 5.0% Ω whichever is			

Page : 5/15

HVC-008-0807

No.	Iten	n		Spec	ification	Test Condition		
14	High	Appear-	· ·			Class ☐ capacitors applied DC voltage		
		ance				(following table) is applied for one hour at		
	Load	Capacit-			·	maximum operation temperature ±3°C then		
	(Life Test)	ance	Class		Within ±3.0% or	shall be set for 48±4 hours at room temperature		
						and the initial measurement shall be		
			0. 1	\/=D	is larger	conducted.		
			Class II	X7R Z5U/Y5U	Within ± 15% Within ± 30%	Applied Voltage :		
		Q		Than 30pF:		Rated Voltage Applied Voltage		
		Class I			Q ≦ 330 ≥ 275 + 2.5× C			
		Tan δ		nar.	maximum	V≤250Vdc 150%Rated Voltage		
		Class II		7R	5.0%	Less Than 1KVdc 120%Rated Voltage		
				/Y5U	5.0%	More Than 1KVdc(include 1KV)		
		Insulation	1,000N	/Ω or 50/C	Ω whichever is	- TKVdc(iiicidde TKV)		
		Resistance	smalle	r.	(C in Farad)	1010/1001/		
						1210/100V capacitance more than 1.0uF applied voltage of 120% rated voltage		
						Temperature : max. operation temperature		
						Test Time: 1000 +12/-0Hr		
						Current Applied: 50 mA Max.		
						Measure at room temperature after cooling for		
						Class I: 24 ± 2 Hours		
						Class II: 48 ± 4 Hours		
15	Vibration	Appear-	No me	chanical da	mage shall occur	Solder the capacitor on P.C. Board shown in		
		ance	01			Fig 2. before testing.		
		Capacit-		aracteristic	Cap. Change	Vibrata the conscitor with amplitude of 1 Emm		
		ance	Class		Within ± 2.5% or	Vibrate the capacitor with amplitude of 1.5mm P-P changing the frequencies from 10Hz to		
			(NPO/	SL)	± 0.25pFwhichever is larger	55Hz and back to 10Hz in about 1 min.		
			Class	X7R	Within ± 7.5%	33112 and back to 10112 in about 1 min.		
			Ulass	Z5U/Y5U	Within ± 20%	Repeat this for 2 hours each in 3perpendicula		
		Q	To satisfy the specified initial value			directions.		
		Class I	l o oan	To satisfy the specified littlat value				
		Tan δ	To sati	sfy the spec	ified initial value			
		Class II						
		Insulation		sfy the spec	ified initial value			
		Resistance)					

Page : 6/15



Fig.1
P.C. Board for Bending Strength Test

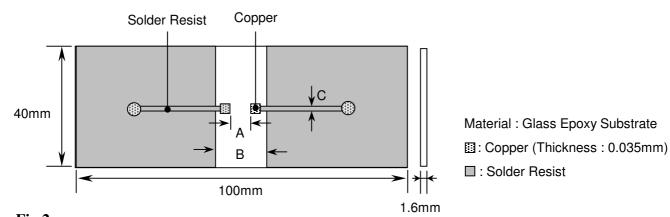
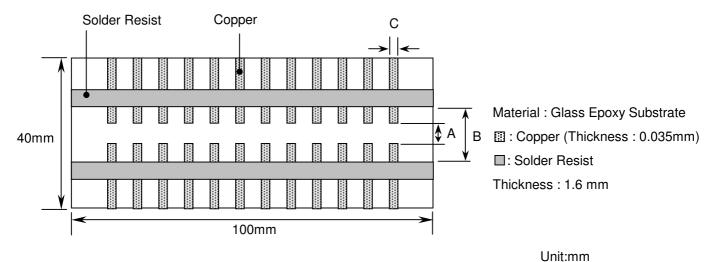


Fig.2 Test Substrate



Туре	A	В	С
0201	0.2	0.9	0.4
0402	0.5	1.5	0.6
0603	1.0	3.0	1.0
0805	1.2	4.0	1.6
1206	2.2	5.0	2.0
1210	2.2	5.0	2.9
1808	3.5	7.0	2.5
1812	3.5	7.0	3.7
2208	4.5	8.0	2.5
2211	4.5	8.0	3.0
2220	4.5	8.0	5.6
1825	3.5	7.0	6.9
2225	4.5	8.0	7.0

Page: 7/15

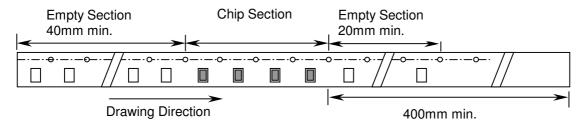


8. Packing

8.1 Bulk Packing

According to customer request.

8.2 Chip Capacitors Tape Packing



8.3 Material And Quantity

Tape	0201	0402	0603/	0805
Material	T≦0.33mm	T≦0.55mm	T≦0.90mm	T>0.90mm
Paper	15,000 pcs/Reel	10,000 pcs/Reel	4,000 pcs/Reel	NA
Plastic	NA	NA	NA	3,000 pcs/Reel

Tape		1206	1210/1808		
Material	T≦0.90mm	$0.90 \text{mm} < T \le 1.25 \text{mm}$	T>1.25mm	T≦1.25mm	T>1.25mm
Paper	4,000 pcs/Reel	NA	NA	NA	NA
Plastic	NA	3,000 pcs/Reel	2,000 pcs/Reel	3000 pcs/Reel	2000 pcs/Reel

Tape	1812/1825	/2211/2220	22	25	2208
Material	T≦2.20mm	T>2.20mm	T≦2.20mm	T>2.20mm	T≦2.20mm
Paper	NA	NA	NA	NA	NA
Plastic	1000 pcs/Reel 700 pcs/Reel 1		1000 pcs/Reel	400 pcs/Reel	1000 pcs/Reel

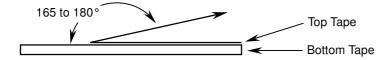
NA: Not Available

8.4 Cover Tape Reel Off Force

8.4.1 Peel-Off Force

 $5 g \cdot f \leq Peel-Off Force \leq 70 g \cdot f$

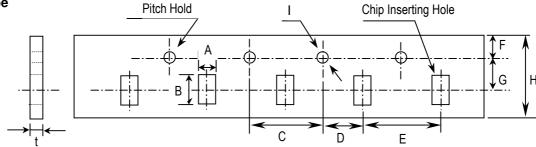
8.4.2 Measure Method



Page: 8/15





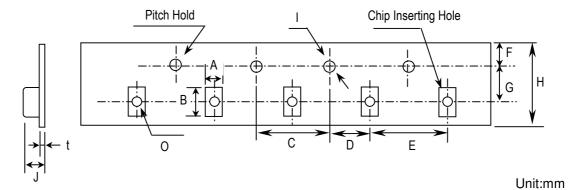


Unit:mm

TYPE	Α	В	С	D	Е
0201	0.37± 0.1	0.67± 0.1	4.00± 0.1	2.00± 0.05	2.00± 0.1
0402	0.61± 0.1	1.20± 0.1			
0603	1.10± 0.2	1.90± 0.2			4.00± 0.1
0805	1.50± 0.2	2.30± 0.2			
1206	1.90± 0.2	3.50± 0.2			
1210	2.90± 0.2	3.60± 0.2			

TYPE	F	G	Н		t
0201	1.75± 0.10	3.50± 0.05	8.0± 0.30	φ 1.50 +0.10/-0	1.10 max.
0402					
0603					
0805					
1206					
1210					

8.6 Plastic Tape



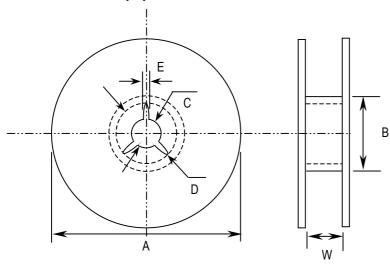
Type	Α	В	С	D	Е	F
0805	1.5±0.2	2.3±0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
1206	1.9±0.2	3.5±0.2				
1210	2.9±0.2	3.6±0.2				
1808	2.5±0.2	4.9±0.2				
1812	3.6±0.2	4.9±0.2			8.0± 0.1	
1825	6.9±0.2	4.9±0.2				
2208	2.5±0.2	6.1±0.2				
2211	3.2±0.2	6.1±0.2				
2220	5.4±0.2	6.1±0.2				
2225	6.9±0.2	6.1±0.2				



Type	G	Н		J	t	0
0805	3.5± 0.05	8.0± 0.3	φ 1.5+0.1/-0	3.0 max.	0.3 max.	0.15 min.
1206						
1210						
1808	5.5± 0.05	12.0 ± 0.3		4.0 max.		
1812						
1825						
2208						
2211						
2220						
2225						

8.7 Reel Dimensions

Reel Material: Polystyrene



Unit:mm

Type	А	В	С	D	E	W
0201	φ 382 max	arphi 50 min	φ 13± 0.5	φ 21± 0.8	2.0±0.5	10± 0.15
0402						
0603						
0805						
1206						
1210						
1808	φ 178±0.2	φ 60±0.2				13±0.3
1812						
1825						
2208						
2211						
2220						
2225						

Page: 10/15



Precautionary Notes:

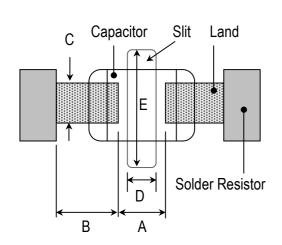
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40 °C and 70%RH. We recommend that the capacitors be used within 6 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering .

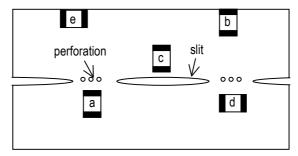


EIA Code	Chip (mm)		Land (mm)				
EIA Code	L	W	Α	В	С	D	Е
0201	0.60	0.30	0.2~0.3	0.2~0.4	0.2~0.4		
0402	1.00	0.50	0.3~0.5	0.3~0.5	0.4~0.6		1
0603	1.60	0.80	0.4~0.6	0.6~0.7	0.6~0.8		1
0805	2.00	1.25	0.7~0.9	0.6~0.8	0.8~1.1		1
1206	3.20	1.60	2.2~2.4	0.8~0.9	1.0~1.4	1.0~2.0	3.2~3.7
1210	3.20	2.50	2.2~2.4	1.0~1.2	1.8~2.3	1.0~2.0	4.1~4.6
1808	4.60	2.00	2.8~3.4	1.8~2.0	1.5~1.8	1.0~2.8	3.6~4.1
1812	4.60	3.20	2.8~3.4	1.8~2.0	2.3~3.0	1.0~2.8	4.8~5.3
1825	4.60	6.35	2.8~3.4	1.8~2.0	5.1~5.8	1.0~4.0	7.1~8.3
2208	5.70	2.00	4.0~4.6	2.0~2.2	1.5~1.8	1.0~4.0	3.6~4.1
2211	5.70	2.80	4.0~4.6	2.0~2.2	2.0~2.6	1.0~4.0	4.4~4.9
2220	5.70	5.00	4.0~4.6	2.0~2.2	3.5~4.8	1.0~4.0	6.6~7.1
2225	5.70	6.35	4.0~4.6	2.0~2.2	5.1~5.8	1.0~4.0	7.1~8.3

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended. Susceptibility to stress is in the order of: a>b>c and d>e



Page: 11/15

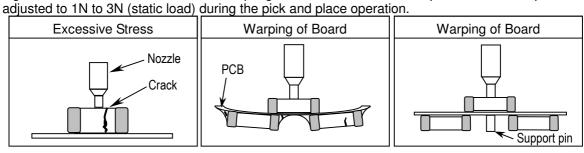


2.3 Layout Recommendation

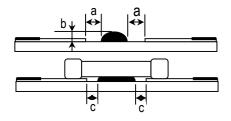
Example	Use of Common Solder Land	Solder With Chassis	Use of Common Solder Land With Other SMD
Need to Avoid	Chip Solder Adhesive PCB Solder Land	Chassis Excessive Solder a	Solder Land
Recommendation	Chip Solder Resist Adhesive PCB Solder Land	Solder Resist β $\alpha > \beta$	

3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically



3.2 Amount of Adhesive



 Example : 0805 & 1206

 a
 0.2mm min.

 b
 70 ~ 100 μm

 C
 Do not touch the solder land

Page: 12/15

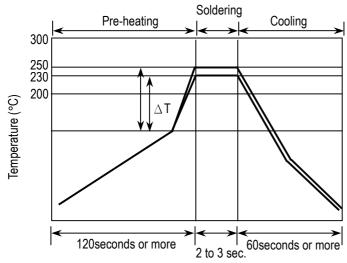


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to $250\,^{\circ}$ C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



Soldering Method	Change in Temp.($^{\circ}$ C)
1206 and Under	$\Delta T \le 100 \sim 130 \text{ max}.$

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
 - a. Flux flows to easily
 - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

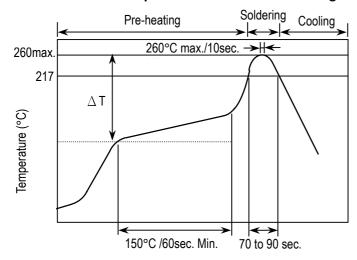
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) between the solvent and the chips must be less than 100 °C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed $3\,\text{C/Sec}$.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



The cycles of soldering: Twice (max.)

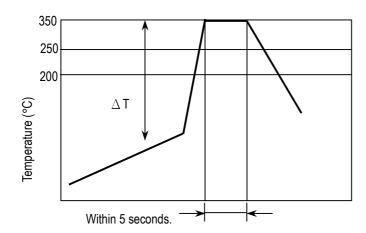
Soldering Method	Change in Temp.(°C)	
1206 and Under	∆T ≦ 190 °C	
1210 and Over	∆T ≦ 130 °C	

Page: 13/15



4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



Soldering Method	Change in Temp.(°C)
1206 and Under	Δ T \leq 190 $^{\circ}$ C
1210 and Over	Δ T \leq 130 $^{\circ}$ C

How to Solder Repair by Solder Iron

1) Selection of the soldering iron tip

The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.

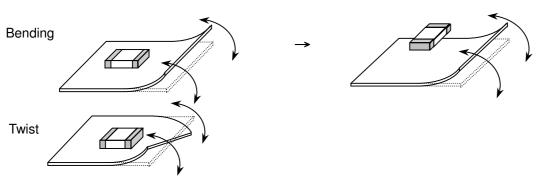
- 2) recommended solder iron condition
 - a.) Preheat the substrate to $(60\,^{\circ}\text{C})$ to $120\,^{\circ}\text{C}$ to $120\,^{\circ}\text{C}$ on a hot plate. Note that due to the heat loss, the actual setting of the hot plate may have to be higher. (For example $100\,^{\circ}\text{C}$ to $150\,^{\circ}\text{C}$)
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350 ℃., and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
 - f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
 - g.) After soldering operation, let the products cool down gradually in the room temperature.

5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.

Higher potential of crack

Lower potential of crack



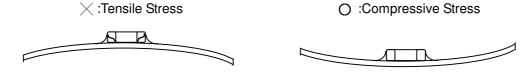
5.2 There is a potential of crack if board is warped due to excessive load by check pin



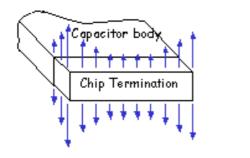
Page: 14/15

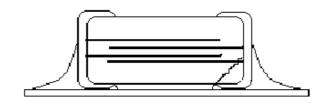


- 5.3 Mechanical stress due to warping and torsion.
 - (a) Crack occurrence ratio will be increased by manual separation.
 - (b) Crack occurrence ratio will be increased by tensile force, rather than compressive force.



Capacitor Stress Analysis



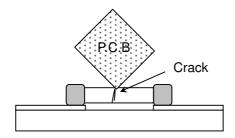


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40 °C and under humidity of 20 to 75% RH. The shelf life of capacitors is 6 months.

Page: 15/15

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Multilayer Ceramic Capacitors MLCC - SMD/SMT category:

Click to view products by IHHEC / Holy Stone manufacturer:

Other Similar products are found below:

M39014/02-1218V M39014/02-1225V M39014/22-0631 D55342E07B523DR-T/R NCA1206X7R104K16TRPF NIN-FB391JTRF NIN-FC2R7JTRF NMC0402NPO220J50TRPF NMC0402X5R105K6.3TRPF NMC0402X5R224K6.3TRPF NMC0402X7R103J25TRPF NMC0402X7R153K16TRPF NMC0603NPO101F50TRPF NMC0603NPO1R8C50TRPF NMC0603NPO20J50TRPF NMC0603NPO20J50TRPF NMC0603X5R475M6.3TRPF NMC0805NPO270J50TRPF NMC0805NPO681F50TRPF NMC0805NPO820J50TRPF NMC0805X7R224K16TRPLPF NMC0805X7R224K25TRPF NMC1206X7R102K50TRPF NMC1206X7R475K10TRPLPF NMC-Q0402NPO8R2D200TRPF C1206C101J1GAC C1608C0G2A221J C1608X7R1E334K C2012C0G2A472J 2220J2K00562KXT 1812J2K00332KXT CDR04BX104AKSR CDR31BX103AKWR CDR33BX104AKUR CDR33BX683AKUS CGA2B2C0G1H010C CGA2B2C0G1H040C CGA2B2C0G1H050C CGA2B2C0G1H060D CGA2B2C0G1H070D CGA2B2C0G1H120J CGA2B2C0G1H151J CGA2B2C0G1H1R5C CGA2B2C0G1H2R2C CGA2B2C0G1H390J CGA2B2C0G1H391J CGA2B2C0G1H3R3C CGA2B2C0G1H680J CGA2B2C0G1H6R8D CGA2B2C0G1H820J CGA2B2X8R1H152K